DATA SHEET



MOS FIELD EFFECT TRANSISTOR 2SK4144

SWITCHING N-CHANNEL POWER MOS FET

DESCRIPTION

The 2SK4144 is N-channel MOS Field Effect Transistor designed for high current switching applications.

ORDERING INFORMATION

PART NUMBER	LEAD PLATING	PACKING	PACKAGE	
2SK4144-AZ Note		Vinyl bag 200 p/bag		
2SK4144-S12-AZ Note	Sn-Ag-Cu	Tube 50 p/tube	Isolated TO-220 typ. 2.2 g	

Note Pb-free (This product does not contain Pb in the external electrode.)

FEATURES

<R>

• Low on-state resistance

 $R_{DS(on)1}$ = 5.8 m Ω MAX. (Vgs = 10 V, ID = 35 A)

 $R_{DS(on)2} = 7.3 \text{ m}\Omega \text{ MAX.} \text{ (Vgs} = 4.5 \text{ V, Ip} = 35 \text{ A)}$

Low input capacitance

C_{iss} = 5500 pF TYP. (V_{DS} = 10 V)

• Built-in gate protection diode

ABSOLUTE MAXIMUM RATINGS (TA = 25°C)

Drain to Source Voltage (V _{GS} = 0 V)	VDSS	60	V
Gate to Source Voltage (VDS = 0 V)	Vgss	±20	V
Drain Current (DC) (Tc = 25°C)	I _{D(DC)}	±70	Α
Drain Current (pulse) Note1	I _{D(pulse)}	±280	Α
Total Power Dissipation (Tc = 25°C)	P _{T1}	35	W
Total Power Dissipation (T _A = 25°C)	P _{T2}	2.0	W
Channel Temperature	Tch	150	°C
Storage Temperature	T _{stg}	-55 to +150	°C
Repetitive Avalanche Current Note2	lar	49.5	Α
Repetitive Avalanche Energy Note2	Ear	245	mJ

Notes 1. PW \leq 10 μ s, Duty Cycle \leq 1%

2. T_{ch} \leq 150°C, V_{DD} = 30 V, R_G = 25 Ω , V_{GS} = 20 \rightarrow 0 V, L = 100 μ H

THERMAL RESISTANCE

Channel to Case Thermal Resistance $R_{th(ch-C)}$ 3.57 °C/W Channel to Ambient Thermal Resistance $R_{th(ch-A)}$ 62.5 °C/W

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(Isolated TO-220)



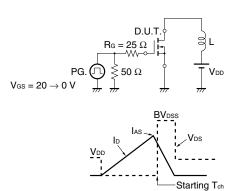


<R> ELECTRICAL CHARACTERISTICS (TA = 25°C)

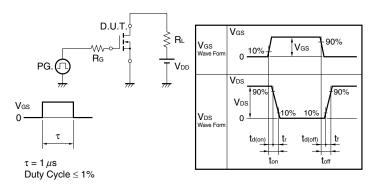
CHARACTERISTICS	SYMBOL	TEST CONDITIONS	MIN.	TYP.	MAX.	UNIT
Zero Gate Voltage Drain Current	IDSS	V _{DS} = 60 V, V _{GS} = 0 V			10	μΑ
Gate Leakage Current	Igss	V _{GS} = ±20 V, V _{DS} = 0 V			±10	μΑ
Gate to Source Cut-off Voltage	V _{GS(off)}	V _{DS} = 10 V, I _D = 1 mA	1.5	2.0	2.5	V
Forward Transfer Admittance Note	yfs	V _{DS} = 10 V, I _D = 35 A	28	56		S
Drain to Source On-state Resistance Note	RDS(on)1	V _{GS} = 10 V, I _D = 35 A		4.7	5.8	mΩ
	R _{DS(on)2}	V _{GS} = 4.5 V, I _D = 35 A		5.3	7.3	mΩ
Input Capacitance	Ciss	V _{DS} = 10 V,		5500		pF
Output Capacitance	Coss	V _{GS} = 0 V,		1050		pF
Reverse Transfer Capacitance	Crss	f = 1 MHz		350		pF
Turn-on Delay Time	t _{d(on)}	V _{DD} = 30 V, I _D = 35 A,		20		ns
Rise Time	tr	V _{GS} = 10 V,		12.2		ns
Turn-off Delay Time	t _{d(off)}	$R_G = 0 \Omega$		100		ns
Fall Time	tf			9.5		ns
Total Gate Charge	Q _G	V _{DD} = 48 V,		96		nC
Gate to Source Charge	Q _G s	V _{GS} = 10 V,		18		nC
Gate to Drain Charge	Q _{GD}	I _D = 70 A		23.5		nC
Body Diode Forward Voltage Note	V _{F(S-D)}	I _F = 70 A, V _{GS} = 0 V		0.9	1.5	V
Reverse Recovery Time	trr	I _F = 70 A, V _{GS} = 0 V,		48		ns
Reverse Recovery Charge	Qrr	di/dt = 100 A/ <i>μ</i> s		69		nC

Note Pulsed

TEST CIRCUIT 1 AVALANCHE CAPABILITY

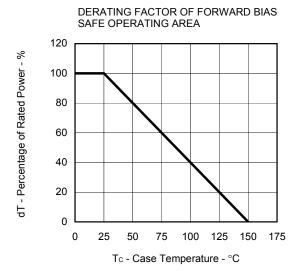


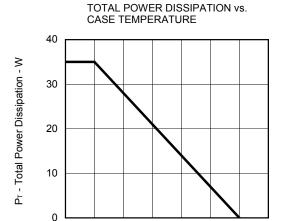
TEST CIRCUIT 2 SWITCHING TIME



TEST CIRCUIT 3 GATE CHARGE

TYPICAL CHARACTERISTICS (TA = 25°C)





0

25

50

75

100

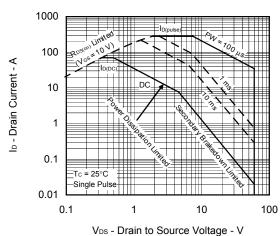
Tc - Case Temperature - °C

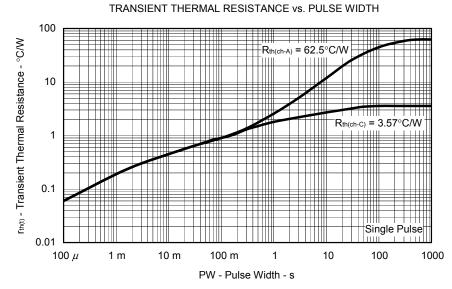
125

150

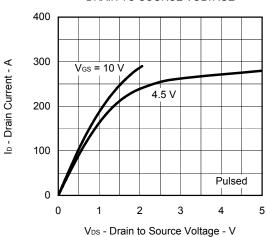
175

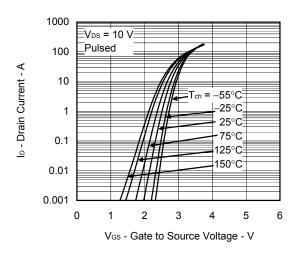
FORWARD BIAS SAFE OPERATING AREA





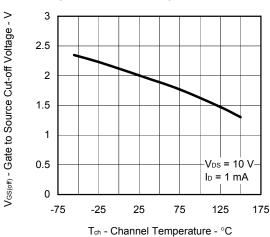




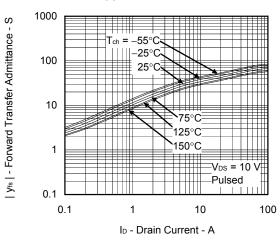


FORWARD TRANSFER CHARACTERISTICS

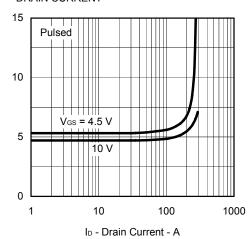
GATE TO SOURCE CUT-OFF VOLTAGE vs. CHANNEL TEMPERATURE



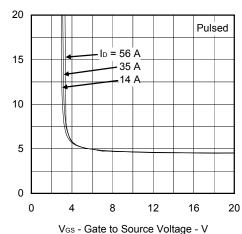
FORWARD TRANSFER ADMITTANCE vs. DRAIN CURRENT



DRAIN TO SOURCE ON-STATE RESISTANCE vs. DRAIN CURRENT

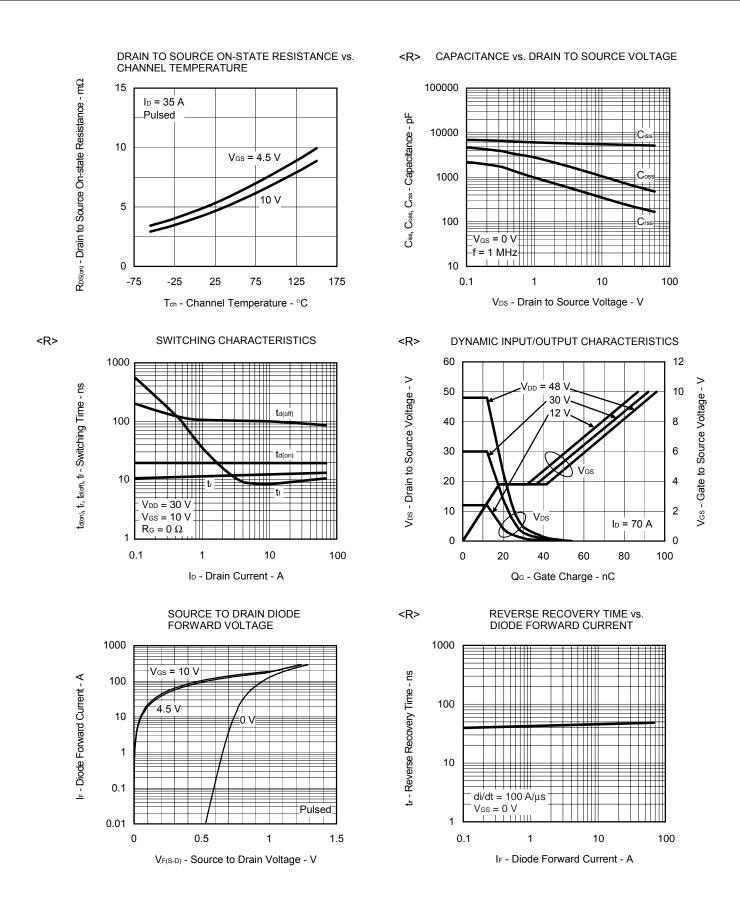


DRAIN TO SOURCE ON-STATE RESISTANCE vs. GATE TO SOURCE VOLTAGE

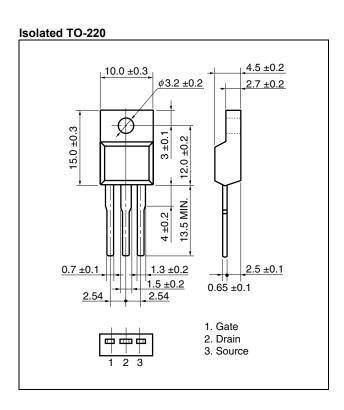


R_{DS(ση)} - Drain to Source On-state Resistance - mΩ

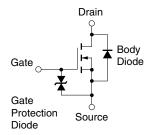
 $\mathsf{R}_{\mathsf{DS}(\mathsf{on})}$ - Drain to Source On-state Resistance - $\mathsf{m}\Omega$



PACKAGE DRAWING (Unit: mm)



EQUIVALENT CIRCUIT

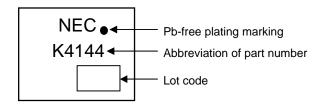


Remark The diode connected between the gate and source of the transistor serves as a protector against ESD.

When this device actually used, an additional protection circuit is externally required if a voltage exceeding the rated voltage may be applied to this device.



MARKING INFORMATION



RECOMMENDED SOLDERING CONDITIONS

The 2SK4144 should be soldered and mounted under the following recommended conditions.

For soldering methods and conditions other than those recommended below, please contact an NEC Electronics sales representative.

For technical information, see the following website.

Semiconductor Device Mount Manual (http://www.necel.com/pkg/en/mount/index.html)

Soldering Method	Soldering Conditions	Recommended Condition Symbol
Wave soldering	Maximum temperature (Solder temperature): 260°C or below Time: 10 seconds or less Maximum chlorine content of rosin flux: 0.2% (wt.) or less	THDWS
Partial heating	Maximum temperature (Pin temperature): 300°C or below Time (per side of the device): 3 seconds or less Maximum chlorine content of rosin flux: 0.2% (wt.) or less	P300

Caution Do not use different soldering methods together (except for partial heating).

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